S	earc	h N	otes	

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/701,073	YOSHIOKA ET AL.	
Examiner	Art Unit	
Brian R. Peugh	2187	

	SEAR	CHED	
Class	Subclass	Date	Examiner
			-
	•••		

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
711	165,154	6/9/2006	BRP
711	203	6/9/2006	BRP
7189	105	6/9/2006	BRP
	-		
			-

(INCLUDING SI				
		DATE	EXMR	
		• .		
			ļ	
			ļ	
	-		(	